

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/657,122	WANG, HANK	
Examiner		Art Unit		Page 1 of 1
Seung H. Lee		2876		

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	C	US-4,337,571	07-1982	Grevstad et al.	29/623.2
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**NON-PATENT DOCUMENTS**

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